


<b>Search Notes</b> 	<b>Application/Control No.</b> 10539615	<b>Applicant(s)/Patent Under Reexamination</b> KOBAYASHI, SHU
	<b>Examiner</b> YUN QIAN	<b>Art Unit</b> 4162

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN search and EAST search (PGpub, USPAT, EPO, JPO, Inventor), 564/464 and 568/879 text search,Consult with Jenny McNeil	8/13/2008	YQ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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